Form PTO-1449 (Modified)
U.S. Department of Commerce
Patent and Trademark Office

Aity, Dockat No. Serial No.
20103/030290 10/829,495
Applicants
Taylor ct al.
Filing Date Group Art Unit

2419

2004-04-22

INFORMATION DISCLOSURE STATEMENT

(Use several sheets if necessary)

	U.S. PATENT DOCUMENTS							
*EXAMINER INITIALS	NO.	DOCUMENT NUMBER	ISSUE DATE	INVENTOR(S)	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE	
	1.	4905233	1990-02-27	Cain et al.				
	2.	5016244	1991-05-14	Massey, Jr. et al.				
	3.	5065392	1991-11-12	Sibbitt et al.				
	4.	5408461	1995-04-18	Uriu et al.				
	5.	5559959	1996-09-24	Foglar				
	6.	5894475	1999-04-13	Bruno et al.				
	7.	5926456	1999-07-20	Takano et al.				
	8.	6028863	2000-02-22	Sasagawa et al.				
	9.	6038219	2000-03-14	Mawhinney et al.				
	10.	6167025	2000-12-26	Hsing et al.				
	11.	6181675	2001-01-30	Miyamoto				
	12.	6185695	2001-02-06	Murphy et al.				
	13.	6195416	2001-02-27	DeCaluwe et al.				
	14.	6311288	2001-10-30	Heeren et al.				
	15.	6377548	2002-04-23	Chuah				
	16.	6424629	2002-07-23	Rubino et al.				
	17.	6456306	2002-09-24	Chin et al.				
	18.	6553015	2003-04-22	Sato				
	19.	6556659	2003-04-29	Bowman-Amuah				
	20.	6581166	2003-06-17	Hirst et al.				

EXAMINER	/Ashley Shivers/	DATE CONSIDERED	03/09/2009
	,		

*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

EXAMINER	CITE	DOCUMENT	ISSUE	INVENTOR(S)	CLASS	SUBCLASS	FILING DATE
INITIALS	NO.	NUMBER	DATE	, ,			IF APPROPRIATE
	21.	6594268	2003-07-15	Aukia et al.			
	22.	6597689	2003-07-22	Chiu et al.			
	23.	6643254	2003-11-04	Kijitani et al,			
	24.	6716165	2004-04-06	Flanders et al.			
	25.	6763476	2004-07-13	Dangi et al.			
	26.	6781952	2004-08-24	Shirakawa			
	27.	6823477	2004-11-23	Cheng et al.			
	28.	6826184	2004-11-30	Bryenton et al.			
	29.	6829223	2004-12-07	Richardson et al.			
	30.	6862351	2005-03-01	Taylor			
	31.	6865170	2005-03-08	Zendle			
	32.	6925578	2005-08-02	Lam et al.			
	33.	6981039	2005-12-27	Cerami et al.			
	34.	6983401	2006-01-03	Taylor			
	35.	6990616	2006-01-24	Botton-Dascal et al.			
	36.	7027053	2006-04-11	Berndt et al.			
	37.	7093155	2006-08-15	Aoki			
	38.	7120148	2006-10-10	Batz et al.			
	39.	7120819	2006-10-10	Gurer et al.			
	40.	7146000	2006-12-05	Hollman et al.			
	41.	7165192	2007-01-16	Cadieux et al.			
	42.	7200148	2007-04-03	Taylor et al.			
	43.	7209452	2007-04-24	Taylor et al.			
	44.	7240364	2007-07-03	Branscomb et al.			
	45.	7275192	2007-09-25	Taylor et al.			
	46.	7350099	2008-03-25	Taylor et al.			
	47.	7460468	2008-12-02	Taylor et al.			
	48.	7466646	2008-12-16	Taylor et al.			

ALL REFERENCES CONSIDERED EXCEPT WHERE LINED THROUGH. /A.S./

EXAMINER INITIALS	CITE NO.	DOCUMENT NUMBER	ISSUE DATE	INVENTOR(S)	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
	1.	20010000700	2001-05-03	Eslambolchi et al.			
	2.	20020001307	2002-01-03	Nguyen et al.			
	3.	20020072358	2002-06-13	Schneider et al.			
	4.	20030043753	2003-03-06	Nelson et al.			
	5.	20030051195	2003-03-13	Bosa et al.			
	6.	20030086413	2003-05-08	Tartarelli et al.			
	7.	20030091024	2003-05-15	Stumer			
	8.	20030128692	2003-07-10	Mitsumori et al.			
	9.	20040090973	2004-05-13	Christie et al.			
	10.	20040125776	2004-07-01	Haugli et al.			
	11.	20040141464	2004-07-22	Taylor et al.			
	12.	20040172574	2004-09-02	Wing et al.			
	13.	20050135237	2005-06-23	Taylor et al.			
	14.	20050135254	2005-06-23	Taylor et al.			
	15.	20050135263	2005-06-23	Taylor et al.			
	16.	20050138203	2005-06-23	Taylor et al.			
	17.	20050138476	2005-06-23	Taylor et al.			
	18.	20050172160	2005-08-04	Taylor et al.			
	19.	20050172174	2005-08-04	Taylor et al.			
	20.	20050237925	2005-10-27	Taylor et al.			
	21.	20050238006	2005-10-27	Taylor et al.			
	22.	20050238007	2005-10-27	Taylor et al.			
	23.	20050238024	2005-10-27	Taylor et al.			
	24.	20050240840	2005-10-27	Taylor et al.			
	25.	20070168200	2007-07-19	Shimizu	The state of		

ALL REFERENCES CONSIDERED EXCEPT WHERE LINED THROUGH. /A.S./

FOREIGN PATENT DOCUMENTS								
*Examiner	Cite	Document	Publication	Country	Class	Subclass	Translation	
Initials	No.	Number	Date				Yes	No

	OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, etc.)
1.	Don Ryan, The Teleo Handbook For New Technicians - An Introduction To Teleo Technology And Troubleshooting, October 27, 2000, [retrieved from http://www.darkwing.netlaaron/teleo.doc, accessed on 11/2/2006, 67 pages.

ALL REFERENCES CONSIDERED EXCEPT WHERE LINED THROUGH. /A.S./